TOSHIBA Bi-CMOS Integrated Circuit Silicon Monolithic

TB62725BP,TB62725BF,TB62725BFN

8-bit Constant-Current LED Driver of the 3.3-V and 5-V Power Supply Voltage Operation

The TB62725BP/BF/BFN are comprised of constant-current drivers designed for LEDs and LED displays. The output current value can be set using an external resistor.

As a result, all outputs will have virtually the same current levels.

This driver incorporates an 8-bit constant-current output, an 8-bit shift register, an 8-bit latch circuit and an 8-bit AND-gate circuit.

These drivers have been designed using the Bi-CMOS process.

Features

Output current capability and number of outputs: 90 mA × 8 outputs

Constant current range: 5 to 80 mA

Application output voltage:

0.7 V (output current 5 to 80 mA)

0.4 V (output current 5 to 40 mA)

For anode-common LEDs

Input signal voltage level: 3.3-V and 5-V CMOS level (Schmitt trigger input)

Maximum output terminal voltage: 17 V

Serial data transfer rate: 20 MHz (max, cascade connection) Operating temperature range: T_{opr} = -40 to 85°C

Package:

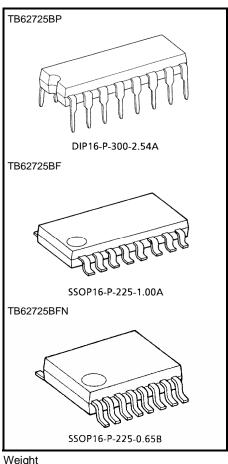
Type BP:	DIP16-P-300-2.54A
Type BF:	SSOP16-P-225-1.00A
Type BFN:	SSOP16-P-225-0.65B

Package and pin layout: Pin layout and functionality are similar to those of the TB62705C series and TB62725A series.

(Each characteristic value is different.)

Constant-current accuracy (all outputs on)

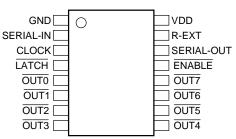
Output Voltage	bltage Current Error Current Error between Bits between ICs		Output Current
≧ 0.4 V	+6%	±15%	5 to 40 mA
≧ 0.7 V	1070	1070	5 to 90 mA



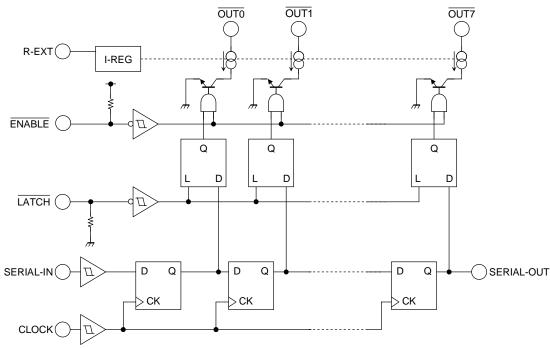
DIP16-P-300-2.54A: 1.11 g (typ.) SSOP16-P-225-1.00A: 0.14 g (typ.) SSOP16-P-225-0.65B: 0.07 g (typ.)

Pin Assignment (top view)

Pin layout and functionality are similar to those of the TB62705C (each characteristic value is different.), and TB62725A (The characteristic to be the same if the minimum current range is equal to or more than 5 mA).



Block Diagram



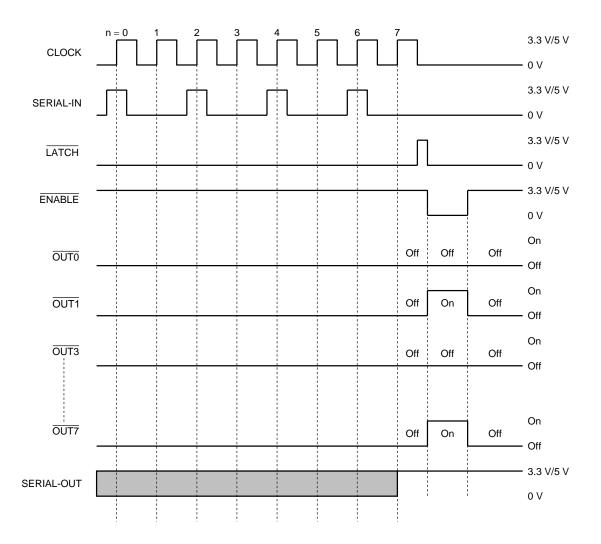
Truth Table

CLOCK	LATCH	ENABLE	SERIAL-IN	OUTO OUT5 OUT7	SERIAL-OUT
	Н	L	Dn	Dn Dn – 5 Dn – 7	Dn – 7
	L	L	Dn + 1	No change	Dn – 6
	н	L	Dn + 2	Dn + 2 Dn - 3 Dn - 5	Dn – 5
\rightarrow	Х	L	Dn + 3	Dn + 2 Dn - 3 Dn - 5	Dn – 5
	х	н	Dn + 3	Off	Dn – 5

Note 1: $\overline{OUT0}$ to $\overline{OUT7}$ = On when Dn = H; to $\overline{OUT0}$ to $\overline{OUT7}$ = Off when Dn = L. In order to ensure that the level of the power supply voltage is correct, an external resistor must be

connected between R-EXT and GND.

Timing Diagram



Warning: Latch circuit is leveled-latch circuit. Be careful because it is not triggered-latch circuit.

and off does.

Attention: This IC can be used in 3.3 V or 5.0 V. However, use the V_{DD} power supply and the input level in the same voltage system.

3

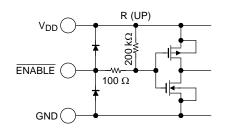
Note 2: The latches circuit holds data by pulling the LATCH terminal Low. And, when LATCH terminal is a high-level, latch circuit doesn't hold data, and it passes from the input to the output. When ENABLE terminal is a low-level, output terminal OUT0 to OUT7 respond to the data, and on

Terminal Description

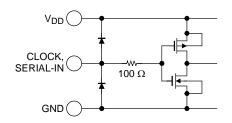
Pin No.	Pin Name	Function
1	GND	GND terminal for control logic.
2	SERIAL-IN	Input terminal for serial data for data shift register.
3	CLOCK	Input terminal for clock for data shift on rising edge.
4	LATCH	Input terminal for data strobe. When the LATCH input is driven High, data is latched. When it is pulled Low, data is hold.
5 to 12	OUT0_to OUT7	Constant-current output terminals.
13	ENABLE	Input terminal for output enable. All outputs (\overline{OUTO} to $\overline{OUT7}$) be turned off, when the \overline{ENABLE} terminal is driven High. And are turned on, when the terminal is driven Low.
14	SERIAL-OUT	Output terminal for serial data input on SERIAL-IN terminal.
15	R-EXT	Input terminal used to connect an external resistor. This regulated the output current.
16	V _{DD}	3.3-V and 5-V supply voltage terminal.

Equivalent Circuits for Inputs and Outputs

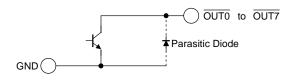
ENABLE Terminal



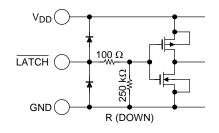
CLOCK, SERIAL-IN Terminal



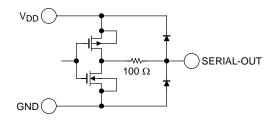
OUT0 to OUT7 Terminals



LATCH Terminal



SERIAL-OUT Terminal



Absolute Maximum Ratings (Topr = 25°C)

Characteristics		Symbol	Rating	Unit	
Supply voltage		V _{DD}	6	V	
Input voltage		V _{IN}	-0.2 to V _{DD} + 0.2	V	
Output current		IOUT	90	mA/ch	
Output voltage		V _{OUT}	-0.2 to 17	V	
Power	BP-type (when not mounted)	P _{d1}	1.47		
dissipation	BF/BFN-type (when not mounted)	P _{d2}	0.37	w	
(Note 3)	BF/BFN-type (on PCB)		0.78		
Thermal	BP-type (when not mounted)		85		
resistance (Note 3)	BF/BFN-type (when not mounted)	R _{th (j-a) 2}	330	°C/W	
	BF/BFN-type (on PCB)	R _{th (j-a) 3}	160		
Operating tempe	Operating temperature		-40 to 85	°C	
Storage temperature		T _{stg}	-55 to 150	°C	

Note 3: BP-type: Power dissipation is delated by 11.76 mW/°C if device is mounted on PCB and ambient temperature is above 25°C.

BF and BFN-type: Power dissipation is delated by 7.69 mW/°C if device is mounted on PCB and ambient temperature is above 25°C. With device mounted on glass-epoxy PCB of less than 40% Cu and of dimensions 50 mm \times 50 mm \times 1.6 mm

Recommended Operating Conditions (T_{opr} = -40°C to 85°C unless otherwise specified)

Characteristics	Symbol	Test Condition	Min	Тур.	Max	Unit
Supply voltage	V _{DD}	—	3		5.5	V
Output voltage	V _{OUT}	—	_	0.7	4	V
	IOUT	Each DC 1 circuit	5	—	80	mA/ch
Output current	I _{OH}	SERIAL-OUT	_		-1	mA
	I _{OL}	SERIAL-OUT	_	_	1	
Input voltage	VIH		$0.7 \times V_{DD}$	_	V _{DD} + 0.15	mA
	VIL		-0.15		$0.3 \times V_{DD}$	
Clock frequency	f CLK	Cascade Connected	_		20	MHz
LATCH pulse width	twLATCH	—	50	_	_	ns
ENABLE pulse width		$I_{OUT} \ge 20 \text{ mA}$	2000	_		ns
(Note 4)	^t wENABLE	I _{OUT} < 20 mA	3000	_	_	115
CLOCK pulse width	twCLOCK		25	_		
Set-up time for CLOCK terminal	tSETUP1]	10			
Hold time for CLOCK terminal	t _{HOLD}		10			ns
Set-up time for LATCH terminal	tSETUP2		50	_		

Note 4: When the pulse of the low level is inputted to the ENABLE terminal held in the high level.

Electrical Characteristics ($V_{DD} = 5 V$, Ta = 25°C unless otherwise specified)

Characteristics	Symbol	Test Co	ondition	Min	Тур.	Max	Unit
Supply voltage	V _{DD}	Normal operation		4.5	5	5.5	V
	I _{OUT1}	$\begin{array}{l} V_{OUT}=0.4 \ \text{V}, \\ V_{DD}=3.3 \ \text{V} \end{array}$	R _{EXT} = 490 Ω	29.84	35.10	40.36	mA
Output current	I _{OUT2}	$V_{OUT} = 0.4 \text{ V},$ $V_{DD} = 5 \text{ V}$	R _{EXT} = 250 Ω	29.58	34.80	40.02	
Output current	I _{OUT3}	V _{OUT} = 0.7 V, V _{DD} = 3.3 V	$R_{EXT} = 490 \Omega$	58.40	68.70	79.00	
	I _{OUT4}	$V_{OUT} = 0.7 V,$ $V_{DD} = 5 V$	$R_{EXT} = 250 \Omega$	57.55	67.70	77.85	
Output current	ΔI_{OUT1}	$V_{OUT} = 0.4 V$, All outputs ON	$R_{EXT} = 490 \ \Omega$	—	±1.5	±6	%
Error between bits	ΔI_{OUT2}	$V_{OUT} = 0.7 V$, All outputs ON	$R_{EXT} = 250 \Omega$	—	±1.5	±6	70
Output leakage current	I _{OZ}	$V_{OUT} = 15 V$			1	5	μA
	V _{IH}	-	_			V _{DD}	V
Input voltage	VIL	_		GND		0.3 V _{DD}	
SOUT terminal		$I_{OH} = 1.0 \text{ mA}, V_{DD} = 3.3 \text{ V}$		_	_	0.3	v
SOUT terminal	VOL	V _{OL} I _{OH} = 1.0 mA, V _{DD} = 5 V			_	0.3	V
		$I_{OL} = -1.0 \text{ mA}, V_{DD} = 3.3 \text{ V}$		3	_		v
Output voltage	VOH	I _{OH} = 1.0 mA, V _{DD} = 5 V		4.7	_		v
Output current Supply voltage Regulation	%/V _{DD}	$V_{DD} = 3 \text{ V} \rightarrow 5.5 \text{ V}$	$V_{DD} = 3 \text{ V} \rightarrow 5.5 \text{ V}$		±1.5	±5.0	%
Pull-up resistor	R (Up)	ENABLE terminal		100	200	400	kΩ
Pull-down resistor	R (Down)	LATCH terminal		125	250	500	kΩ
	I _{DD} (OFF) 1	$V_{OUT} = 15.0 V$	$R_{EXT} = OPEN$		0.1	0.5	
	I _{DD} (OFF) 2	$V_{OUT} = 15.0 V$, All outputs OFF	$R_{EXT} = 490 \ \Omega$	1	3	5	
	IDD (OFF) 3	V _{OUT} = 15.0 V, All outputs OFF	R _{EXT} = 250 Ω	3	6	8	
Supply current	IDD (ON) 1	$V_{OUT} = 0.7 V,$ All outputs ON	R _{EXT} = 490 Ω	_	6	9	mA
		Same as the above,	$T_{opr} = -40^{\circ}C$	_	_	15	1
		V _{OUT} = 0.7 V, All outputs ON	- R _{EXT} = 250 Ω	_	12	17	
	IDD (ON) 2	Same as the above, $T_{opr} = -40^{\circ}C$		_		29	

Switching Characteristics (T_{opr} = 25°C unless otherwise specified)

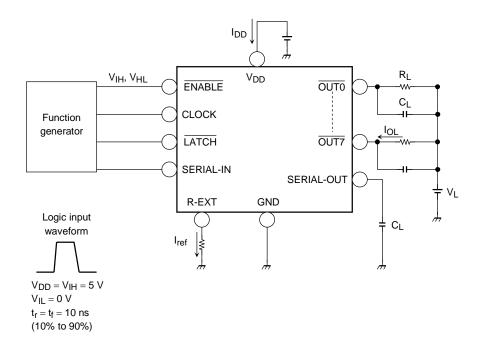
Characteristics	Symbol	Test Condition	Min	Тур.	Max	Unit
	^t pLH1	$ \begin{array}{l} CLK \text{ to } \overline{OUTn} \ , \ \overline{LATCH} \ = ``\text{H}", \\ \overline{ENABLE} \ = ``\text{L}" \end{array} $	_	150	300	
	t _{pLH2}	\overline{LATCH} to \overline{OUTn} , $\overline{ENABLE} = "L"$		140	300	
	t _{pLH3}	$\overline{ENABLE} \text{to} \overline{OUTn} \ , \ \overline{LATCH} \ = ``H"$	_	140	300	
Propagation delay time	t _{pLH}	CLK to SERIAL OUT	2	5	_	ns
	t _{pHL1}	$\begin{array}{llllllllllllllllllllllllllllllllllll$	_	170	340	
	t _{pHL2}	\overrightarrow{LATCH} to \overrightarrow{OUTn} , \overrightarrow{ENABLE} = "L"	_	170	340	
	tpHL3	$\overline{ENABLE} \text{to} \overline{OUTn} \ , \ \overline{LATCH} \ = \text{``H''}$	_	170	340	
	t _{pHL}	CLK to SERIAL OUT	2	5	_	
Output rise time	tor	10 to 90% of voltage waveform	40	85	150	ns
Output fall time	t _{of}	90 to 10% of voltage waveform	40	70	150	ns
Maximum clock rise time	t _r	Cascade connection isn't guarantee.	—	_	5	us
Maximum clock fall time	t _f	(Note 5)	_		5	us

Conditions: (refer to test circuit.)

 T_{opr} = 25°C, V_{DD} = V_{IH} = 5 V, V_{OUT} = 0.7 V, V_{IL} = 0 V, R_{EXT} = 490 $\Omega,~V_L$ = 5.0 V, R_L = 100 $\Omega,~C_L$ = 10.5 pF

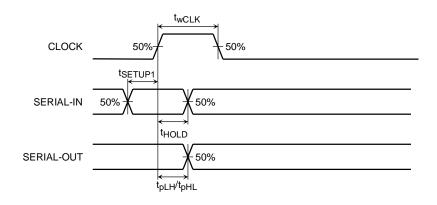
Note 5: If the device is connected in a cascade and t_r/t_f for the waveform is large, it may not be possible to achieve the timing required for data transfer. Please consider the timings carefully.

Test Circuit

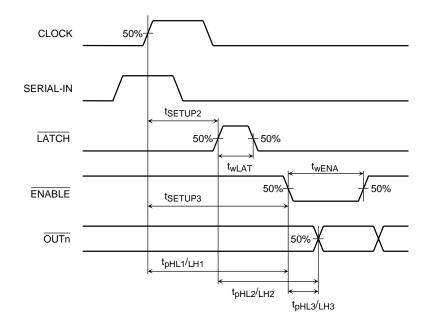


Timing Waveforms

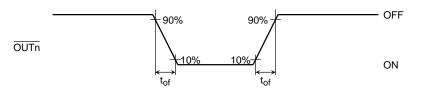
1. CLOCK, SERIAL-IN, SERIAL-OUT

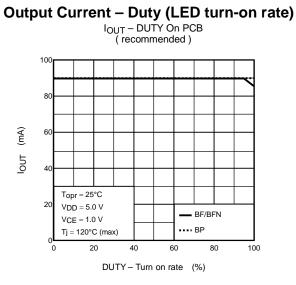


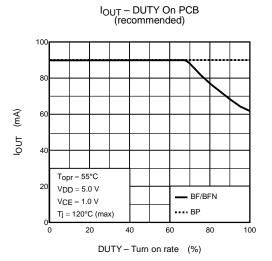
2. CLOCK, SERIAL-IN, LATCH , ENABLE , OUTn

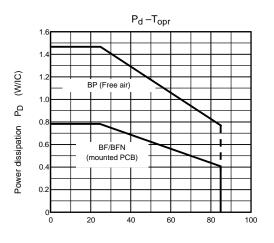


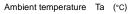
3. OUTn

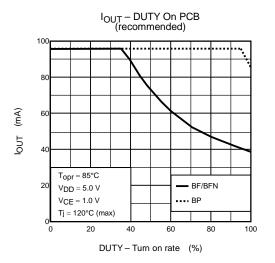


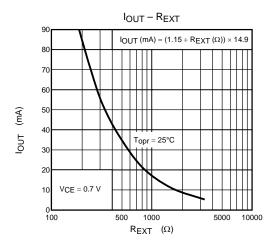












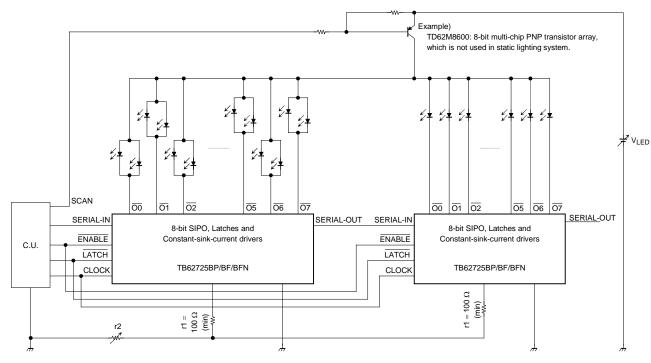
TB62725BP/BF/BFN

Application Circuit (example 1): The general composition in static lighting of LED.

More than $V_{\text{LED}}(V) \ge V_{\text{f}}$ (total max) +0.7 is recommended with the following application circuit with the LED power supply V_{LED} .

r1: The setup resistance for the setup of output current of every IC.

r2: The variable resistance for the brightness control of every LED module.



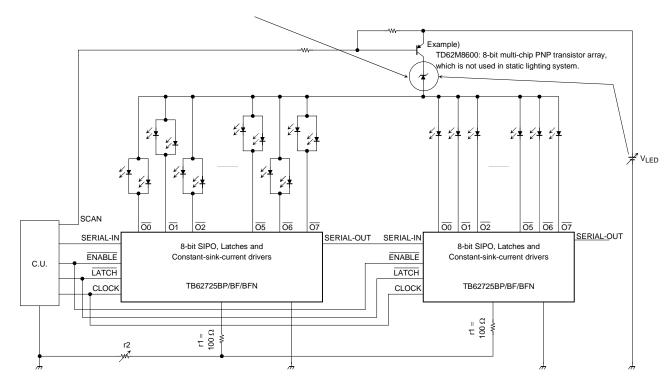
10

2006-06-13

TB62725BP/BF/BFN

Application Circuit (example 2): When the condition of V_{LED} is $V_{LED} > 17 V$.

The unnecessary voltage is one effective technique as to making the voltage descend with the zennor diode.



11

2006-06-13

TB62725BP/BF/BFN

Application Circuit (example 3): When the condition of V_{LED} is $V_f + 0.7 < V_{LED} < 17$ V.

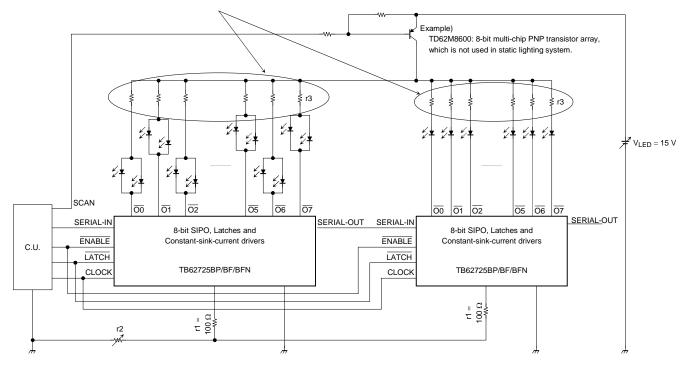
 V_{OUT} = $V_{LED}-V_{f}$ = 0.7 to 1.0 V is the most suitable for $V_{OUT}.$

Surplus VOUT causes an IC fever and the useless consumption electric power.

It is the one way of being effective to build in the r3 in this problem.

r3 can make a calculation to the formula r3 (ohms) = surplus VOUT/IOUT.

Though the resistance parts increase, the fixed constant current performance is kept.



12

2006-06-13

Notes

- Operation may become unstable due to the electromagnetic interference caused by the wiring and other phenomena. To counter this, it is recommended that the IC be situated as close as possible to the LED module. If overvoltage is caused by inductance between the LED and the output terminals, both the LED and the terminals may suffer damage as a result.
- There is only one GND terminal on this device when the inductance in the GND line and the resistor are large, the device may malfunction due to the GND noise when output switching by the circuit board pattern and wiring. To achieve stable operation, it is necessary to connect a resistor between the REXT terminal and the GND line. Fluctuation in the output waveform is likely to occur when the GND line is unstable or when a capacitor (of more than 50 pF) is used.

Therefore, take care when designing the circuit board pattern layout and the wiring from the controller.

This application circuit is a reference example and is not guaranteed to work in all conditions. Be sure to check the operation of your circuits.

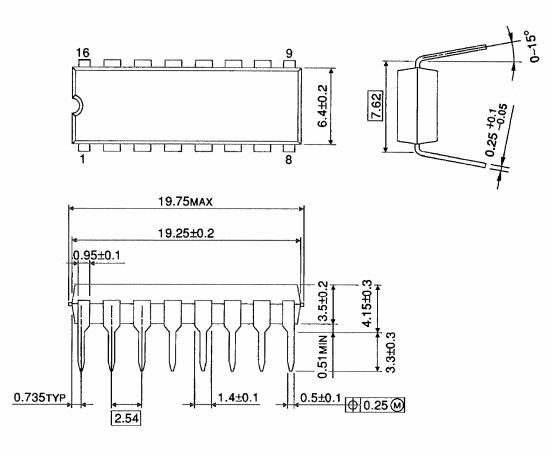
This device does not include protection circuits for over voltage, over current or over temperature. If protection is necessary, it must be incorporated into the control circuitry.

The device is likely to be destroyed if a short-circuit occurs between either of the power supply pins and any of the output terminals when designing circuits, pay special attention to the positions of the output terminals and the power supply terminals (V_{DD} and V_{LED}), and to the design of the GND line.

Package Dimensions

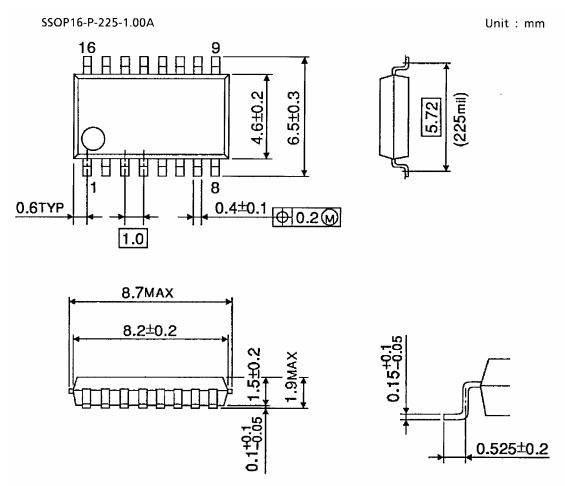
DIP16-P-300-2.54A

Unit : mm



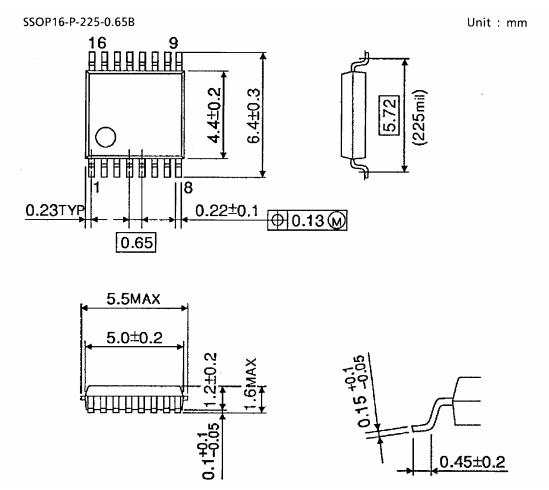
Weight: 1.11 g (typ.)

Package Dimensions



Weight: 0.14 g (typ.)

Package Dimensions



Weight: 0.07 g (typ.)

Notes on Contents

1. Block Diagrams

Some of the functional blocks, circuits, or constants in the block diagram may be omitted or simplified for explanatory purposes.

2. Equivalent Circuits

The equivalent circuit diagrams may be simplified or some parts of them may be omitted for explanatory purposes.

3. Timing Charts

Timing charts may be simplified for explanatory purposes.

4. Application Circuits

The application circuits shown in this document are provided for reference purposes only. Thorough evaluation is required, especially at the mass production design stage. Toshiba does not grant any license to any industrial property rights by providing these examples of application circuits.

5. Test Circuits

Components in the test circuits are used only to obtain and confirm the device characteristics. These components and circuits are not guaranteed to prevent malfunction or failure from occurring in the application equipment.

IC Usage Considerations

Notes on Handling of ICs

- The absolute maximum ratings of a semiconductor device are a set of ratings that must not be exceeded, even for a moment. Do not exceed any of these ratings.
 Exceeding the rating(s) may cause the device breakdown, damage or deterioration, and may result injury by explosion or combustion.
- (2) Use an appropriate power supply fuse to ensure that a large current does not continuously flow in case of over current and/or IC failure. The IC will fully break down when used under conditions that exceed its absolute maximum ratings, when the wiring is routed improperly or when an abnormal pulse noise occurs from the wiring or load, causing a large current to continuously flow and the breakdown can lead smoke or ignition. To minimize the effects of the flow of a large current in case of breakdown, appropriate settings, such as fuse capacity, fusing time and insertion circuit location, are required.
- (3) If your design includes an inductive load such as a motor coil, incorporate a protection circuit into the design to prevent device malfunction or breakdown caused by the current resulting from the inrush current at power ON or the negative current resulting from the back electromotive force at power OFF. IC breakdown may cause injury, smoke or ignition. Use a stable power supply with ICs with built-in protection functions. If the power supply is unstable, the protection function may not operate, causing IC breakdown. IC breakdown may cause injury, smoke or ignition.
- (4) Do not insert devices in the wrong orientation or incorrectly. Make sure that the positive and negative terminals of power supplies are connected properly. Otherwise, the current or power consumption may exceed the absolute maximum rating, and exceeding the rating(s) may cause the device breakdown, damage or deterioration, and may result injury by explosion or combustion. In addition, do not use any device that is applied the current with inserting in the wrong orientation or incorrectly even just one time.
- (5) Carefully select external components (such as inputs and negative feedback capacitors) and load components (such as speakers), for example, power amp and regulator. If there is a large amount of leakage current such as input or negative feedback condenser, the IC output DC voltage will increase. If this output voltage is connected to a speaker with low input withstand voltage, overcurrent or IC failure can cause smoke or ignition. (The over current can cause smoke or ignition from the IC itself.) In particular, please pay attention when using a Bridge Tied Load (BTL) connection type IC that inputs output DC voltage to a speaker directly.

Points to Remember on Handling of ICs

(1) Heat Radiation Design

In using an IC with large current flow such as power amp, regulator or driver, please design the device so that heat is appropriately radiated, not to exceed the specified junction temperature (Tj) at any time and condition. These ICs generate heat even during normal use. An inadequate IC heat radiation design can lead to decrease in IC life, deterioration of IC characteristics or IC breakdown. In addition, please design the device taking into considerate the effect of IC heat radiation with peripheral components.

(2) Back-EMF

When a motor rotates in the reverse direction, stops or slows down abruptly, a current flow back to the motor's power supply due to the effect of back-EMF. If the current sink capability of the power supply is small, the device's motor power supply and output pins might be exposed to conditions beyond maximum ratings. To avoid this problem, take the effect of back-EMF into consideration in system design.

RESTRICTIONS ON PRODUCT USE

Handbook" etc. 021023 A

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